

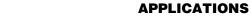
## N-Channel 40 V (D-S) MOSFET

PRODUCT SUMMARY					
V <sub>DS</sub> (V)	$R_{DS(on)}(\Omega)$	I <sub>D</sub> (A)	Q <sub>g</sub> (Typ.)		
40	$0.0F3 \text{ at V}_{GS} = 10 \text{ V}$	55 <sup>d</sup>	F9.5		
40	0.0FI at $V_{GS} = 4.5 \text{ V}$	I 5 <sup>d</sup>	19.5		

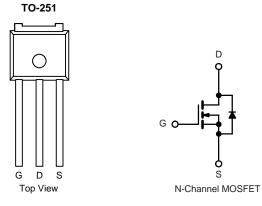
#### **FEATURES**

- · Halogen-free According to IEC 61249-2-21 Definition
- TrenchFET® Power MOSFET
- 100 %  $R_g$  and UIS Tested
- Compliant to RoHS Directive 2002/95/EC





- · Power Supply
  - Secondary Synchronous Rectification
- DC/DC Converter



ABSOLUTE MAXIMUM RATINGS T <sub>C</sub> = 25 °C, unless otherwise noted					
Parameter	Symbol	Limit	Unit		
Drain-Source Voltage	V <sub>DS</sub>	40			
Gate-Source Voltage		V <sub>GS</sub>	± 20	V	
Continuous Drain Current (T <sub>.1</sub> = 150 °C)	T <sub>C</sub> = 25 °C	1-	55 <sup>d</sup>		
Continuous Drain Current (1) = 130 °C)	T <sub>C</sub> = 70 °C	l <sub>D</sub>	I 5 <sup>d</sup>		
Pulsed Drain Current		I <sub>DM</sub>	165	A .	
Avalanche Current		I <sub>AS</sub>	H4		
Single Avalanche Energy <sup>a</sup>	L = 0.1 mH	E <sub>AS</sub>	Ϊ8	mJ	
Mariana Barra Birahan A	T <sub>C</sub> = 25 °C	В	Í 5.5 <sup>b</sup>	10/	
Maximum Power Dissipation <sup>a</sup>	T <sub>A</sub> = 25 °C <sup>c</sup>	P <sub>D</sub>	2.7	W	
Operating Junction and Storage Temperature Range		T <sub>J</sub> , T <sub>stg</sub>	- 55 to 150	°C	

THERMAL RESISTANCE RATINGS					
Parameter	Symbol	Limit	Unit		
Junction-to-Ambient (PCB Mount) <sup>c</sup>	R <sub>thJA</sub>	ĺ4	°C/W		
Junction-to-Case (Drain)	R <sub>thJC</sub>	2.Ï	C/VV		

#### Notes:

- a. Duty cycle  $\leq$  1 %.
- b. See SOA curve for voltage derating.c. When mounted on 1" square PCB (FR-4 material).
- d. Package limited.

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<b>SPECIFICATIONS</b> $T_J = 25^{\circ}$	Symbol	Test Conditions	Min.	Тур.	Max.	Unit	
Static	Oyillooi	rest conditions	141111-	Typ.	IVIQA.	Onic	
Drain-Source Breakdown Voltage	V <sub>DS</sub>	V <sub>DS</sub> = 0 V, I <sub>D</sub> = 250 μA	40				
Gate Threshold Voltage	1	V <sub>DS</sub> = V <sub>GS</sub> , I <sub>D</sub> = 250 μA	1		2.5	V	
Gate-Body Leakage	V <sub>GS(th)</sub>	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$	'		± 250	nA	
Gale-Body Leakage	I <sub>GSS</sub>	V <sub>DS</sub> = 40V, V <sub>GS</sub> = 0 V			1	ПА	
Zana Cata Valtana Brain Current		V <sub>DS</sub> = 40V, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 125 °C			50	μА	
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	$V_{DS} = 40V$ , $V_{GS} = 0V$ , $T_J = 120$ °C			250		
On-State Drain Current <sup>a</sup>	1		EE		250		
On-State Drain Current	I <sub>D(on)</sub>	$V_{DS} \ge 10 \text{ V}, V_{GS} = 10 \text{ V}$	55	0.050		Α	
Drain-Source On-State Resistance <sup>a</sup>	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 22 A		0.0F3		Ω	
		$V_{GS} = 4.5 \text{ V}, I_D = 20 \text{ A}$		0.0FI			
Forward Transconductance <sup>a</sup>	9 <sub>fs</sub>	V <sub>DS</sub> = 15 V, I <sub>D</sub> = 20 A		1€0		S	
Dynamic <sup>b</sup>	<u> </u>		T	<u> </u>			
Input Capacitance	C <sub>iss</sub>			1100		pF	
Output Capacitance	C <sub>oss</sub>	$V_{GS} = 0 \text{ V}, V_{DS} = 15 \text{ V}, f = 1 \text{ MHz}$		460			
Reverse Transfer Capacitance	C <sub>rss</sub>			350			
Total Gate Charge <sup>c</sup>	Qg	$V_{DS}$ = 15 V, $V_{GS}$ = 10 V, $I_{D}$ = 20 A		H6			
Total Cate Gharge				25		nC	
Gate-Source Charge <sup>c</sup>	$Q_{gs}$	$V_{DS} = 15 \text{ V}, V_{GS} = 4.5 \text{ V}, I_{D} = 20 \text{ A}$		Î			
Gate-Drain Charge <sup>c</sup>	$Q_{gd}$			Í .7			
Gate Resistance	$R_{g}$	f = 1 MHz	0.4	2	4	Ω	
Turn-On Delay Time <sup>c</sup>	t <sub>d(on)</sub>			8	16		
Rise Time <sup>c</sup>	t <sub>r</sub>	V <sub>DD</sub> = 15 V, R <sub>I</sub> = 1.5 Ω		9	18	ns	
Turn-Off Delay Time <sup>c</sup>	t <sub>d(off)</sub>	$I_D \cong 10 \text{ A}, V_{GEN} = 10 \text{ V}, R_g = 1 \Omega$		35	53		
Fall Time <sup>c</sup>	t <sub>f</sub>			9	18		
Drain-Source Body Diode Ratings a	nd Characteris	stics T <sub>C</sub> = 25 °C <sup>b</sup>					
Continuous Current	I <sub>S</sub>				55		
Pulsed Current	I <sub>SM</sub>				165	A	
Forward Voltage <sup>a</sup>	V <sub>SD</sub>	I <sub>F</sub> = 10 A, V <sub>GS</sub> = 0 V		0.75	1.5	V	
Reverse Recovery Time	t <sub>rr</sub>	. 35		34	51	ns	
Peak Reverse Recovery Current	I <sub>RM(REC)</sub>	I <sub>F</sub> = 10 A, dI/dt = 100 A/μs		2	3	Α	
Reverse Recovery Charge	Q <sub>rr</sub>			34	51	nC	

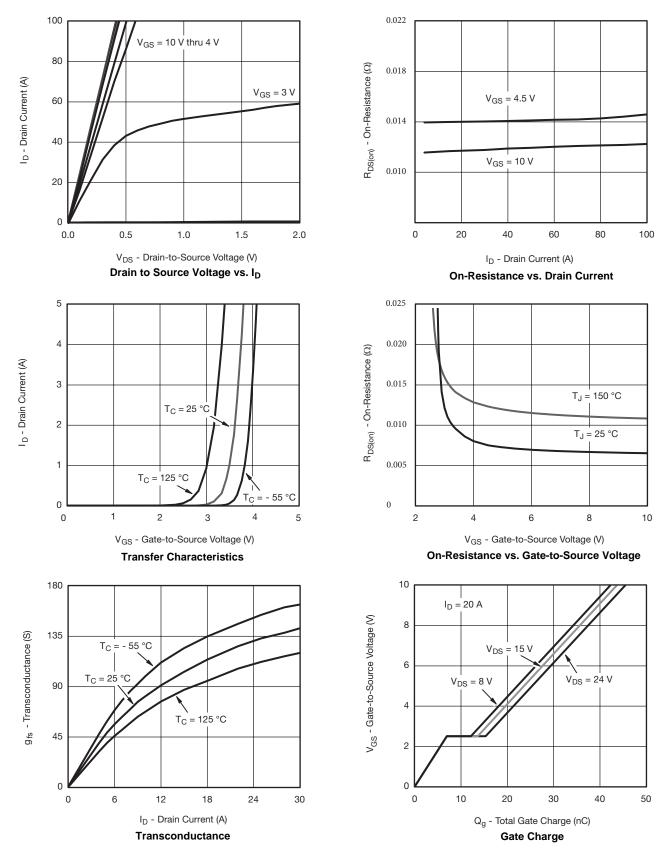
#### Notes:

- a. Pulse test; pulse width  $\leq 300~\mu s,$  duty cycle  $\leq 2~\%.$
- b. Guaranteed by design, not subject to production testing.
- c. Independent of operating temperature.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.



#### TYPICAL CHARACTERISTICS 25 C, unless otherwise noted

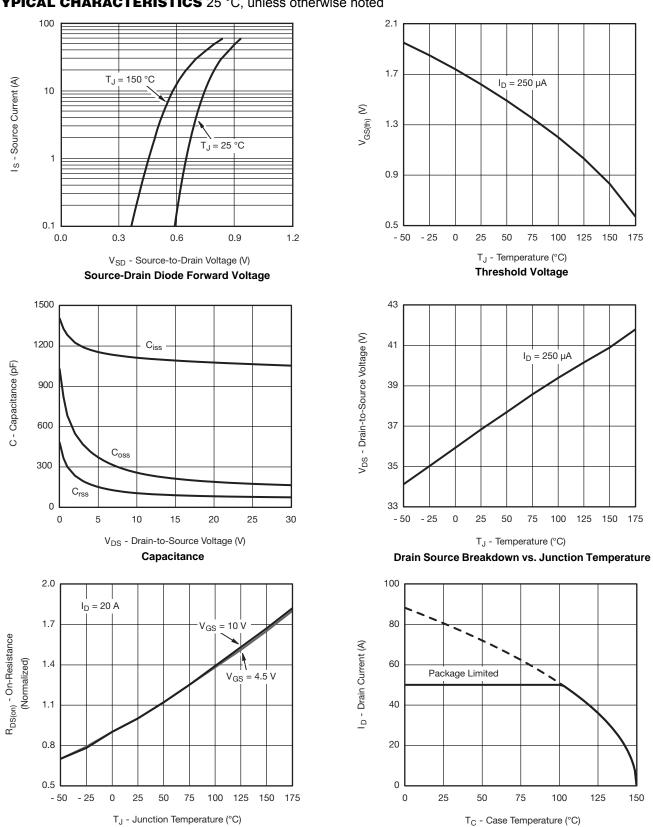


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#### TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

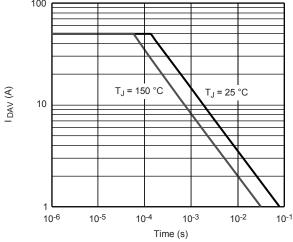
On-Resistance vs. Junction Temperature

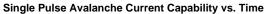


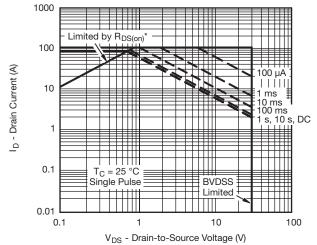
**Current Derating** 



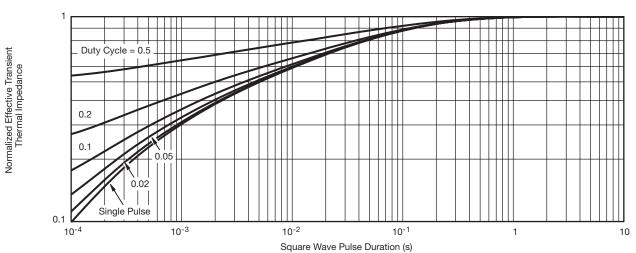
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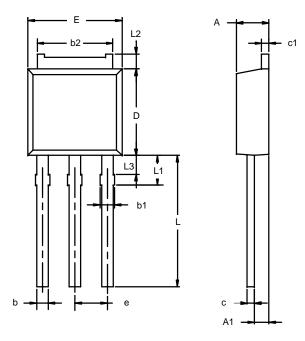
 $^{\star}$  V  $_{GS}$  > minimum V  $_{GS}$  at which R  $_{DS(on)}$  is specified **Safe Operating Area** 



Normalized Thermal Transient Impedance, Junction-to-Case



### **TO-251AA**



Note: Dimension L3 is for reference only.

	MILLIM	IETERS	INCHES		
Dim	Min	Max	Min	Max	
Α	2.21	2.38	0.087	0.094	
<b>A</b> 1	0.89	1.14	0.035	0.045	
b	0.71	0.89	0.028	0.035	
b1	0.76	1.14	0.030	0.045	
b2	5.23	5.43	0.206	0.214	
С	0.46	0.58	0.018	0.023	
с1	0.46	0.58	0.018	0.023	
D	5.97	6.22	0.235	0.245	
Е	6.48	6.73	0.255	0.265	
е	2.28 BSC 0.090 BSC		BSC		
L	3.89	9.53	0.153	0.375	
L1	1.91	2.28	0.075	0.090	
L2	0.89	1.27	0.035	0.050	
L3	1.15	1.52	0.045	0.060	
ECN: S-0 DWG: 53	3946—Rev. E 346	, 09-Jul-01			

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